

Smart-SE

Spectroscopic Ellipsometer for Thin Film Analysis

The Smart SE is an innovative spectroscopic ellipsometer for easy, fast and accurate characterization of thin films, from single to multi-layers.

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➡ Fast and Accurate

The CCD detector of the Smart SE acquires accurate ellipsometric data from 450 -nm to 1000 nm measurement duration ≥ 1 second

➡ Flexible

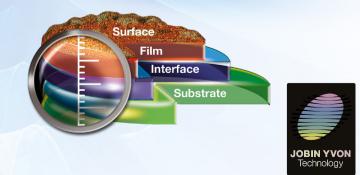
The optical heads of the Smart SE are mounted on a compact manual goniometer that allows data acquisition from 45° to 90° by steps of 5°

Unique Capabilities

- MyAutoView vision system for accurate positioning of the spot on any opaque or transparent substrates
- Seven automated micro spot sizes for measurements of patterned samples
- Full Mueller matrix measurement capability to study anisotropic and depolarizing samples

Thin Film Applications

- Film thickness from a few Å to 15 μm
- Optical constants (n, k)
- Optical bang gap
- Gradient, anisotropy and depolarization



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User Oriented Software Platform

The Smart SE integrates two level of software to fulfill both routine analysis with predefined recipes and advanced analysis with state-of-the-art ellipsometric algorithm:

Auto Soft Routine Mode

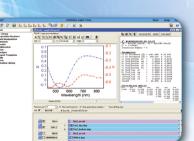
- Auto Soft is an intuitive software that allows inexperienced users to acquire and analyze data in one push of a button
- Four interfaces to control the system, run an experiment, manage the data and perform maintenance test
- Predefined recipes are listed by applications and materials
- Fitting and tabulated data are presented on the same screen for fast reading (goodness of fit, thickness, optical constants, band gap, composition)

DeltaPsi2 Advanced Mode

Over the last two decades, HORIBA Jobin Yvon DeltaPsi2 Ellipsometric software has acquired a brand equity and is recognized as one of the most advanced and powerful commercial ellipsometric software

Export Recipes from DeltaPsi2 to AutoSoft for push button analysis

- Build your model to characterize anisotropic, depolarizing and graded samples
- Customize existing dispersion functions with our unique User Defined Formula and fit new material properties



Specifications

Standard configuration

- Spectral range:
- Spectral resolution:
- ➡ Light source:
- Measurement time:
- → Beam size:
- → Angle of incidence:
- ➡ Sample size:
- Sample alignment:
- → Dimensions:

450 nm to 1000 nm Better than 3 nm at 546 nm Combined Halogen and Blue LED From 1 sec to 60 sec. 75 μm x 150 μm, 100 μm x 250 μm, 100 μm x 500 μm, 150 μm x 150 μm, 250 μm x 250 μm, 250 μm x 500 μm,

- 250 μm x 250 μm, 250 μm x 500 μm 500 μm x 500 μm 45° to 90° by step of 5°
- Up to 200 mm
 - Manual 17 mm height adjustment and tilt 100 cm x 46 cm x 23 cm (W x H x D)

Performance

- → Straight-through air accuracy from 450 to 800 nm: $\Psi = 45^{\circ}\pm0.2^{\circ}$ $\Delta = 0^{\circ}\pm0.5^{\circ}$
- → Thickness accuracy on 1000 Å oxide: 0.4 %
- → Thickness repeatability on 1000 Å oxide: ±0.02%

Options

- → Liquid and electrochemical cells
- Cross hair auto-collimation system



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